

Search Notes

Application/Control No.

10/734,870

Examiner

Jeanette E. Chapman

Applicant(s)/Patent under
Reexamination

LEEK ET AL.

Art Unit

3633

SEARCHED

Class	Subclass	Date	Examiner
search	updated	3/16/2009	JC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
INVENTOR SEARCH	3/16/2009	JC